2SD1199

Silicon NPN epitaxial planer type

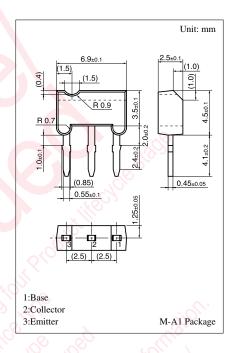
For low-frequency amplification

Features

- High foward current transfer ratio h_{FE}.
- Low collector to emitter saturation voltage V_{CE(sat)}.
- \bullet High emitter to base voltage V_{EBO} .
- Low noise voltage NV.
- M type package allowing easy automatic and manual insertion as well as stand-alone fixing to the printed circuit board.

Absolute Maximum Ratings (Ta=25°C)

Parameter	Symbol	Ratings	Unit
Collector to base voltage	V_{CBO}	50	V
Collector to emitter voltage	V_{CEO}	40	V
Emitter to base voltage	V_{EBO}	15	V
Peak collector current	I_{CP}	100	mA
Collector current	I_{C}	50	mA
Collector power dissipation	P_{C}	400	mW
Junction temperature	T _j	150	°C
Storage temperature	$T_{\rm stg}$	-55 ~ +150	°C



■ Electrical Characteristics (Ta=25°C)

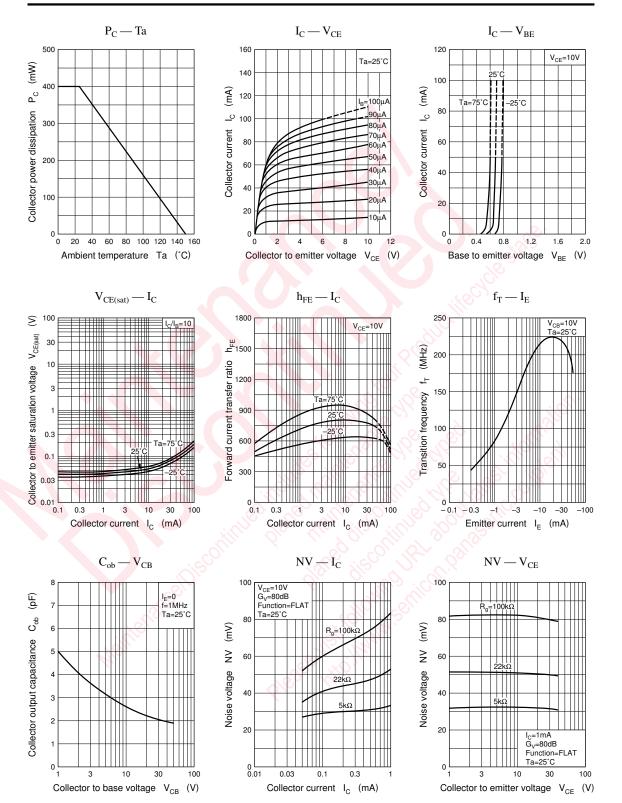
Parameter	Symbol	Conditions	min	typ	max	Unit
Collector cutoff current	I_{CBO}	$V_{CB} = 20V, I_E = 0$	~O()		100	nA
	I_{CEO}	$V_{CE} = 20V, I_B = 0$	2		1	μΑ
Collector to base voltage	V _{CBO}	$I_{\rm C} = 10 \mu {\rm A}, I_{\rm E} = 0$	50			V
Collector to emitter voltage	V _{CEO}	$I_C = 1 \text{mA}, I_B = 0$	40			V
Emitter to base voltage	V _{EBO}	$I_{\rm E} = 10 \mu A, I_{\rm C} = 0$	15			V
Forward current transfer ratio	h _{FE} *	$V_{CE} = 10V, I_C = 2mA$	400		2000	
Collector to emitter saturation voltage	V _{CE(sat)}	$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.05	0.2	V
Transition frequency	f_T	$V_{CB} = 10V, I_E = -2mA, f = 200MHz$		120		MHz
Noise voltage	NV	$V_{CE} = 10V$, $I_{C} = 1$ mA, $G_{V} = 80$ dB $R_{g} = 100$ k Ω , Function = FLAT		80		mV

*hFE Rank classification

Rank	R	S	T	
h_{FE}	400 ~ 800	600 ~ 1200	1000 ~ 2000	

Panasonic 591

Transistor 2SD1199



592 Panasonic

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